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Application No.	Applicant(s)
10/039,434	WANG ET AL.
Examiner	Art Unit
Chat C. Do	2124

SEARCHED					
Class	Subclass	Date	Examiner		
708	300	9/15/2004	CD		
708	314	9/15/2004	CD		
708	308	9/15/2004	CD		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	9/15/2004	CD		
IEEE Explore	9/15/2004	CD		
Inventor Search	9/15/2004	CD		